Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/656,206	FUJII, TAKAYUKI		
Examiner	Art Unit		
Sophia S. Chen	2852		

	SEARCHED Subclass Date Examiner			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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(INCLUDING S	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
None		5/31/2005	SC		